

## Effect of Package Shape on Spurious Coupling Among Microstrip Discontinuities

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Effects of a metallic package on the performance of a microstrip circuit are attributed mainly to the modifications of spurious couplings among various discontinuities. This paper describes a method for computing the effect of the package shape on the interactions among discontinuities. It is shown that chamfering of the corners of a rectangular package can reduce the spurious coupling between two microstrip open-end stubs.

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